

10/532894
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FORM PTO-1449	SERIAL NO. <u>10/532894</u> <small>Not yet assigned</small>	CASE NO. 10808/235
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (use several sheets if necessary)	FILING DATE Herewith	GROUP ART UNIT <u>2823</u> N/A
APPLICANT(S): Josef Böck et al.		

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER <small>Number-Kind Code (if known)</small>	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
<i>AE</i>	A1	US 2002/0079554 A1	June 27, 2002	Okawa et al.		
	A2	US 2001/0045619 A1	November 29, 2001	Dekker et al.		
<i>AE</i>	A3	4,882,294 <u>1989</u>	November 21, 1999	Christenson		
	A4	4,379,726	April 12, 1983	Kamamaru et al.		

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER <small>Number-Kind Code (if known)</small>	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES OR NO
<i>AE</i>	A5	DE 100 44 838 A1	September 11, 2000	Germany		
	A6	WO 97/17726	May 15, 1997	WO		
	A7	JP 62154779	July 9, 1987	Japan		
	A8	JP 58159346	September 21, 1983	Japan		
	A9	JP 58009354	January 19, 1983	Japan		
<i>AE</i>	A10	GB 1 480 050	July 20, 1977	Great Britain		
	A11	DE 26 33 569	July 27, 1976	Germany		

EXAMINER INITIAL		OTHER ART - NON PATENT LITERATURE DOCUMENTS <small>(Include name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.)</small>
<i>AE</i>	A12	Bipolar Transistor with Pedestal Subcollector Regions Self-Aligned Underneath Field Oxide Regions, pgs. 252-253, 700 IBM Technical Disclosure Bulletin, Vol. 31, No. 3, August 1988.
	A13	M. Racanelli, K. Schuegraf, A. Kalburge, A. Kar-Ray, B. Shen, C. Hu, D. Chapek, D. Howard, D. Quon, F. Wang, G. U'ren, L. Lao, J. Zheng, J. Zhang, K. Bell, K. Yin, P. Joshi, S. Akhtar, S. Vo, T. Lee, W. Shi and P. Kempf, Ultra High Speed SiGe NPN for Advanced BICMOS Technology, Silicon RF Platform Technologies, Conexant Systems, Inc.
	A14	Copy of International Search Report from corresponding PCT patent application number PCT/DE03/03552.
<i>AE</i>	A15	Copy of Examination Report from corresponding PCT patent application number PCT/DE03/03552.

EXAMINER <i>Michael J. Stada</i>	DATE CONSIDERED <u>9/28/07</u>
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.